



# FQD11P06 / FQU11P06

## **60V P-Channel MOSFET**

#### **General Description**

These P-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

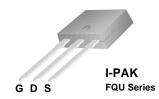
This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand a high energy pulse in the avalanche and commutation modes. These devices are well suited for low voltage applications such as automotive, DC/DC converters, and high efficiency switching for power management in portable and battery operated products.

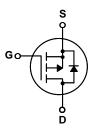
#### **Features**

- -9.4A, -60V,  $R_{DS(on)}$  = 0.185 $\Omega$  @V<sub>GS</sub> = -10 V Low gate charge ( typical 13 nC)
- Low Crss (typical 45 pF)
- Fast switching
- · 100% avalanche tested
- · Improved dv/dt capability
- · RoHS Compliant









# Absolute Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted

Symbol	Parameter		FQD11P06 / FQU11P06	Units
V <sub>DSS</sub>	Drain-Source Voltage		-60	V
I <sub>D</sub>	Drain Current - Continuous (T <sub>C</sub> = 25°C) - Continuous (T <sub>C</sub> = 100°C)		-9.4	Α
			-5.95	Α
I <sub>DM</sub>	Drain Current - Pulsed	(Note 1)	-37.6	Α
V <sub>GSS</sub>	Gate-Source Voltage		± 30	V
E <sub>AS</sub>	Single Pulsed Avalanche Energy (Note 2		160	mJ
I <sub>AR</sub>	Avalanche Current	(Note 1)	-9.4	Α
E <sub>AR</sub>	Repetitive Avalanche Energy	(Note 1)	3.8	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)		-7.0	V/ns
$P_{D}$	Power Dissipation (T <sub>A</sub> = 25°C) *		2.5	W
	Power Dissipation (T <sub>C</sub> = 25°C)		38	W
	- Derate above 25°C		0.3	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range		-55 to +150	°C
T <sub>L</sub>	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

## **Thermal Characteristics**

Symbol	Parameter	Тур	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		3.28	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient *		50	°C/W
R <sub>0JA</sub> Thermal Resistance, Junction-to-Ambient			110	°C/W

Symbol	Parameter	Test Conditions		Min	Тур	Max	Units
Off Cha	racteristics						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$		-60			V
ΔBV <sub>DSS</sub> / ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = -250 μA, Referenced to 25°C			-0.07		V/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = -60 V, V <sub>GS</sub> = 0 V				-1	μΑ
		V <sub>DS</sub> = -48 V, T <sub>C</sub> = 125°C				-10	μΑ
I <sub>GSSF</sub>	Gate-Body Leakage Current, Forward	$V_{GS} = -25 \text{ V}, V_{DS} = 0 \text{ V}$			-	-100	nA
I <sub>GSSR</sub>	Gate-Body Leakage Current, Reverse	V <sub>GS</sub> = 25 V, V <sub>DS</sub> = 0 V				100	nA
On Cha	racteristics						
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = -250 μA		-2.0		-4.0	V
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	$V_{GS} = -10 \text{ V}, I_D = -4.7 \text{ A}$			0.15	0.185	Ω
g <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> = -30 V, I <sub>D</sub> = -4.7 A	(Note 4)		4.9		S
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub>	Input Capacitance Output Capacitance Reverse Transfer Capacitance	$V_{DS} = -25 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHz			420 195 45	550 250 60	pF pF
	ng Characteristics				40	00	Pi
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{DD} = -30 \text{ V, } I_{D} = -5.7 \text{ A,}$ $R_{G} = 25 \Omega$			6.5	25	ns
t <sub>r</sub>	Turn-On Rise Time				40	90	ns
t <sub>d(off)</sub>	Turn-Off Delay Time				15	40	ns
t <sub>f</sub>	Turn-Off Fall Time		(Note 4, 5)		45	100	ns
Qg	Total Gate Charge	V <sub>DS</sub> = -48 V, I <sub>D</sub> = -11.4 A, V <sub>GS</sub> = -10 V			13	17	nC
$Q_{gs}$	Gate-Source Charge				2.0		nC
$Q_{gd}$	Gate-Drain Charge		(Note 4, 5)		6.3		nC
Drain-S	Source Diode Characteristics ar	nd Maximum Ratings	5				
I <sub>S</sub>	Maximum Continuous Drain-Source Diode Forward Current				-9.4	Α	
I <sub>SM</sub>	Maximum Pulsed Drain-Source Diode Forward Current			-	-37.6	Α	
$V_{SD}$	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = -9.4 \text{ A}$				-4.0	V
t <sub>rr</sub>	Reverse Recovery Time	$V_{GS} = 0 \text{ V}, I_{S} = -11.4 \text{ A},$			83		ns
Q <sub>rr</sub>	Reverse Recovery Charge	dI <sub>F</sub> / dt = 100 A/μs	(Note 4)		0.26		μС

- **Notes:**1. Repetitive Rating : Pulse width limited by maximum junction temperature 2. L = 2.1mH,  $I_{AS}$  = -9.4A,  $V_{DD}$  = -25V,  $R_{G}$  = 25  $\Omega$ , Starting  $T_{J}$  = 25°C 3.  $I_{SD}$  ≤ -11.4A, di/dt ≤ 300A/µs,  $V_{DD}$  ≤ BV $_{DSS}$ , Starting  $T_{J}$  = 25°C 4. Pulse Test : Pulse width ≤ 300 $\mu$ s, Duty cycle ≤ 2% 5. Essentially independent of operating temperature

# **Typical Characteristics**

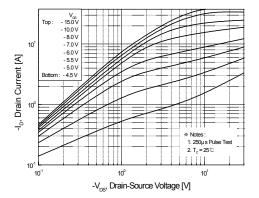


Figure 1. On-Region Characteristics

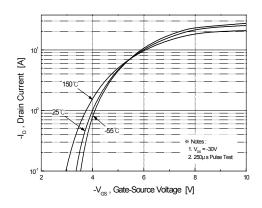


Figure 2. Transfer Characteristics

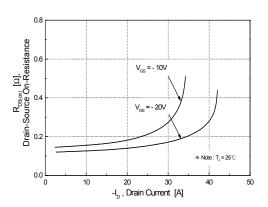


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

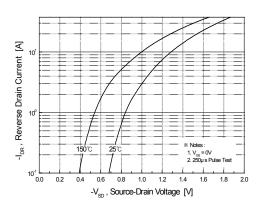


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

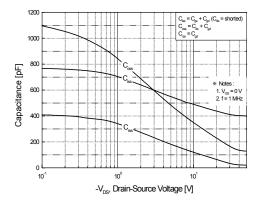


Figure 5. Capacitance Characteristics

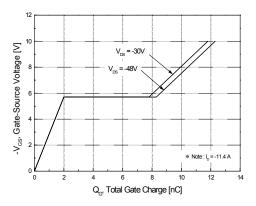
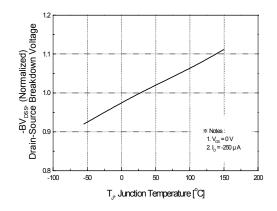


Figure 6. Gate Charge Characteristics

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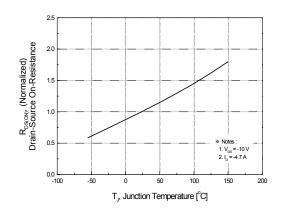
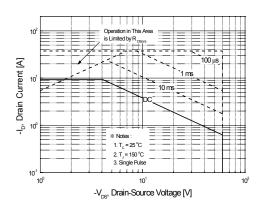


Figure 7. Breakdown Voltage Variation vs. Temperature

Figure 8. On-Resistance Variation vs. Temperature



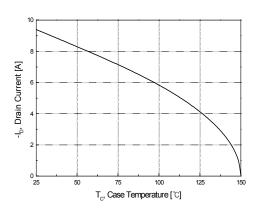


Figure 9. Maximum Safe Operating Area

Figure 10. Maximum Drain Current vs. Case Temperature

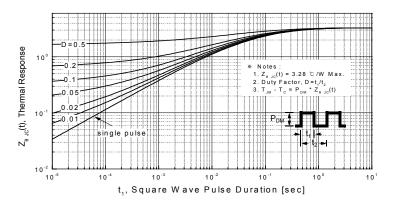
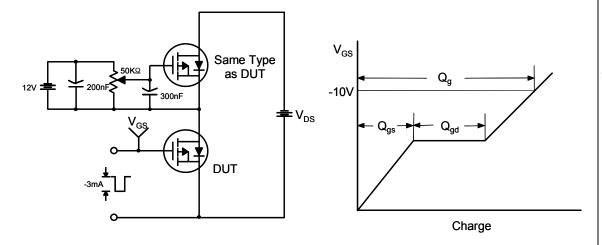


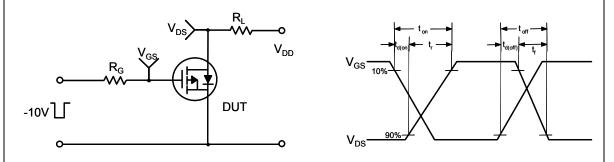
Figure 11. Transient Thermal Response Curve

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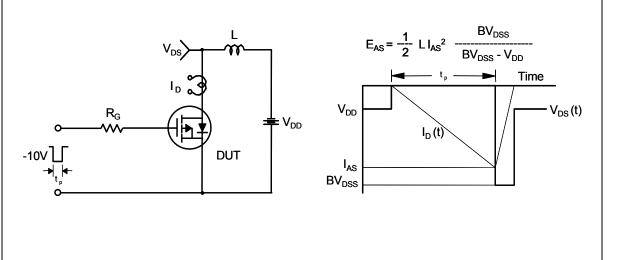
# **Gate Charge Test Circuit & Waveform**



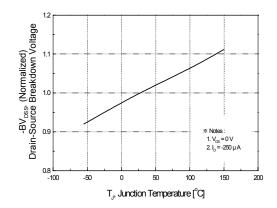
## **Resistive Switching Test Circuit & Waveforms**



# **Unclamped Inductive Switching Test Circuit & Waveforms**







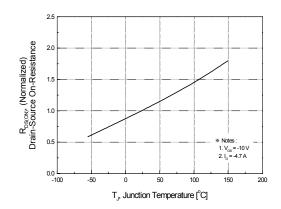
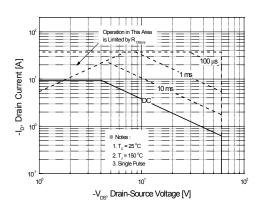


Figure 7. Breakdown Voltage Variation vs. Temperature

Figure 8. On-Resistance Variation vs. Temperature



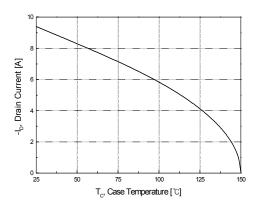


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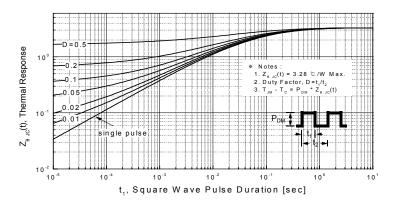


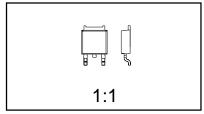
Figure 11. Transient Thermal Response Curve

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#### **Mechanical Dimensions**

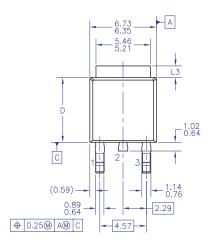
# TO-252 (DPAK) (FS PKG Code 36)

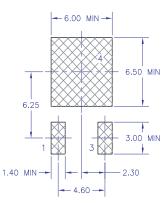




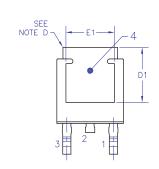
Scale 1:1 on letter size paper Dimensions shown below are in: millimeters

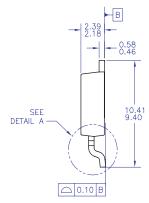
Part Weight per unit (gram): 0.33

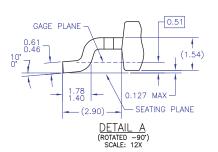




LAND PATTERN RECOMMENDATION







NOTES: UNLESS OTHERWISE SPECIFIED

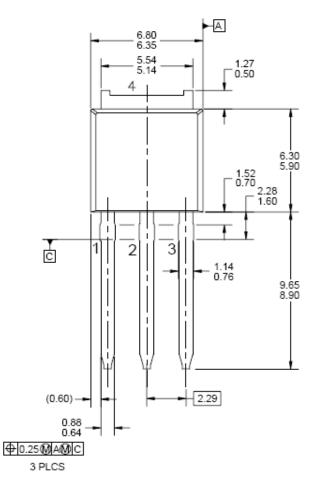
- ALL DIMENSIONS ARE IN MILLIMETERS.
- THIS PACKAGE CONFORMS TO JEDEC, TO—252, ISSUE C, VARIATION AA & AB, DATED NOV. 1999. DIMENSIONING AND TOLERANCING PER ASME Y14.5M—1994. HEAT SINK TOP EDGE COULD BE IN CHAMFERED CORNERS OR EDGE PROTRUSION.
- C)

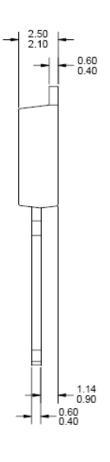
- DIMENSIONS L3,D,E1&D1 TABLE:

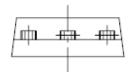
	OPTION AA	OPTION AB
L3	0.89-1.27	1.52-2.03
D	5.97-6.22	5.33-5.59
E1	4.32 MIN	3.81 MIN
D1	5.21 MIN	4.57 MIN



# I - PAK







Dimensions in Millimeters





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